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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

SATO ET AL

Application No.: 10/644,965

Art Unit: 1775

Filed: August 21, 2003

Examiner: Jason Savage

For: Multi-Layer Sliding Part and a Method for Its
Manufacture

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Pursuant to the requirements of 37 CFR §§1.56 and 1.97, the attention of the Examiner is directed to the documents listed on the attached Form PTO-1449. A copy of each of the listed foreign patent documents is attached. Neither this Statement nor the listing of these documents on Form PTO-1449 is an admission that these documents are prior art as to the Applicants nor a representation that a search has been made or that no more pertinent documents exist.

The Applicants' representative certifies that the listed documents were cited in a communication from the European Patent

Office in a counterpart foreign patent application not more than three months before the filing date of this Information Disclosure Statement. A copy of a search report issued by the European Patent Office is attached as an explanation of the relevance of the listed documents.

The Applicants respectfully request that the listed documents be considered by the Examiner and made of record in the referenced patent application.

Respectfully submitted,



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Form PTO-1449 (modified)
List of Patent and Publications For
Applicant's Information Disclosure
Statement
(use several sheets if necessary)

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Atty. Docket. No.:
1050

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Sato et al

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U.S. PATENT DOCUMENTS

Exr's Initial		Document No.							Date	Name	Class	Sub class	Filing Date
	AA	5	2	9	8	3	3	6	3/29/94	Tanaka et al	428	552	2/17/93
	AB												
	AC												
	AD												
	AE												
	AF												
	AG												
	AH												
	AI												
	AJ												

FOREIGN PATENT DOCUMENTS

		Document No.							Date	Country	Class	Sub class	Translation	
													Yes	No
	AK	55	1	6	4	0	5	0	12/20/80	JP			Abstract	
	AL	63	2	8	2	2	2	1	11/18/88	JP			Abstract	
	AM	11	1	3	1	1	0	7	5/18/99	JP			Abstract	
	AN													
	AO													

OTHER ART (Including author, title, date pertinent pages, etc.)

	AP	
	AQ	
	AR	

Examiner

Date considered:

EXAMINER: Initial if reference considered, no matter whether citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.